



N-Ch MOSFET

## Features

· 200V/1.2A,

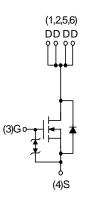
 $R_{DS(ON)}$ = 680m $\Omega$ (max.) @ V<sub>GS</sub>=10V

- ESD Protection
- $\cdot$  100% UIS + R<sub>q</sub> Tested
- Reliable and Rugged
- Lead Free and Green Devices Available
  (RoHS Compliant)

# **Applications**

- · DC-DC converter for Networking.
- Load switch.

**Pin Configuration** 



N-Channel MOSFET

## Absolute Maximum Ratings ( $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Rating	Unit		
Common	Ratings				
$V_{\text{DSS}}$	Drain-Source Voltage		200		
$V_{GSS}$	Gate-Source Voltage	±25	V		
TJ	Maximum Junction Temperature		150	°0	
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	− °C		
I <sub>s</sub>	Diode Continuous Forward Current	T <sub>A</sub> =25°C	1.2	A	
	Continuous Drain Current	T <sub>A</sub> =25°C	1.2		
I <sub>D</sub>		T <sub>A</sub> =70°C	0.96	A	
I <sub>DM</sub> <sup>a</sup>	Pulsed Drain Current	T <sub>A</sub> =25°C	4.8	A	
P	Movimum Dower Dissignation	T <sub>A</sub> =25°C	2.5	10/	
PD	Maximum Power Dissipation	T <sub>A</sub> =70°C	1.6	- W	
$R_{\theta J A}{}^{c}$	Thermal Resistance-Junction to Ambient	t ≤ 10s	50	°C/W	
		Steady State	90	°C/W	
I <sub>AS</sub> <sup>b</sup>	Avalanche Current, Single pulse	L=0.5mH	1	A	
E <sub>AS</sub> <sup>b</sup>	Avalanche Energy, Single pulse L=0.5mH		0.25	mJ	

Note a : Pulse width limited by max. junction temperature.

Note b : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T<sub>j</sub>=25°C). Note c : Surface mounted on 1in<sup>2</sup> pad area.





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# **Electrical Characteristics** ( $T_A = 25^{\circ}C$ unless otherwise noted)

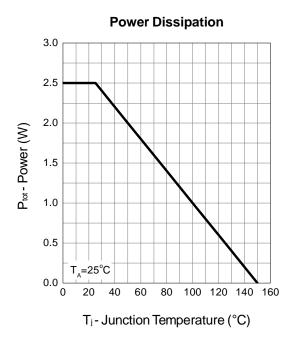
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit	
Static Ch	aracteristics				•		
$BV_{DSS}$	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	200	-	-	V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =160V, V <sub>GS</sub> =0V	-	-	1		
		T <sub>J</sub> =85°C	-	-	30	μA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	3	4	5	V	
$I_{GSS}$	Gate Leakage Current	$V_{GS}$ =±25V, $V_{DS}$ =0V	-	-	±10	μΑ	
$R_{DS(ON)}^{d}$	Drain-Source On-state Resistance	V <sub>GS</sub> =10V, I <sub>DS</sub> =1A	-	570	680	mΩ	
Diode Ch	aracteristics						
$V_{\text{SD}}^{\ \text{d}}$	Diode Forward Voltage	I <sub>SD</sub> =1A, V <sub>GS</sub> =0V	-	0.8	1.3	V	
t <sub>rr</sub>	Reverse Recovery Time		-	48	-	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	−I <sub>SD</sub> =1A, dI <sub>SD</sub> /dt=100A/μs	-	70	-	nC	
Dynamic	Dynamic Characteristics <sup>e</sup>						
$R_{G}$	Gate Resistance	V <sub>GS</sub> =0V,V <sub>DS</sub> =0V,f=1MHz	-	4	-	Ω	
$C_{iss}$	Input Capacitance	V <sub>GS</sub> =0V,	-	280	-		
$C_{oss}$	Output Capacitance	V <sub>DS</sub> =30V,	-	25	-	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	Frequency=1.0MHz	-	8.5	-		
t <sub>d(ON)</sub>	Turn-on Delay Time		-	10	18		
t <sub>r</sub>	Turn-on Rise Time	$V_{DD}$ =30V, R <sub>L</sub> =30 $\Omega$ , $-I_{DS}$ =1A, V <sub>GEN</sub> =10V,	-	8	15	-	
$t_{d(OFF)}$	Turn-off Delay Time	$R_{G}=6\Omega$	-	9	17	ns	
t <sub>f</sub>	Turn-off Fall Time		-	2	4		
Gate Cha	rge Characteristics <sup>e</sup>						
Qg	Total Gate Charge		-	6	9		
$Q_{gs}$	Gate-Source Charge	<sup>−</sup> V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, _I <sub>DS</sub> =1A	-	2	-	nC	
$Q_{gd}$	Gate-Drain Charge		-	1.5	-		

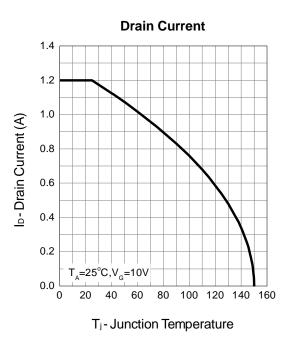
Note d : Pulse test ; pulse width $\leq$ 300µs, duty cycle $\leq$ 2%.

Note e : Guaranteed by design, not subject to production testing.



# **Typical Operating Characteristics**

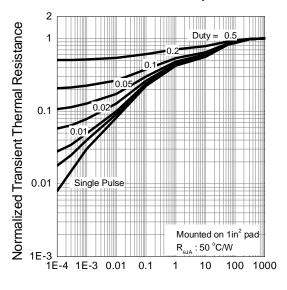




Safe Operation Area 10 Ip-Drain Current (A) 1 300µs 1ms 0.1 10ms 00m 0.01 0.1 =25°C DC 10 100 800 1

V<sub>DS</sub> - Drain - Source Voltage (V)

**Thermal Transient Impedance** 

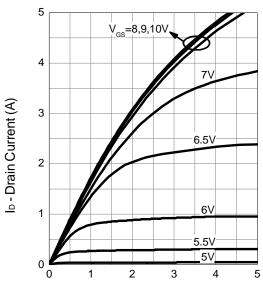


Square Wave Pulse Duration (sec)

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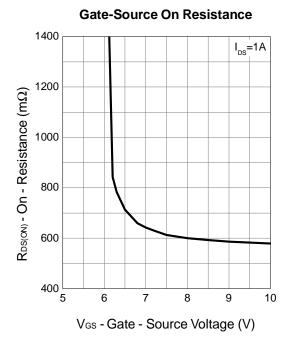
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**Output Characteristics** 

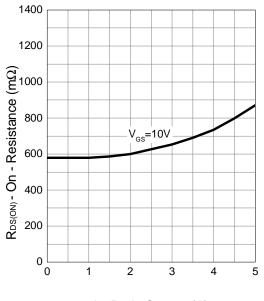
VDS-Drain - Source Voltage (V)



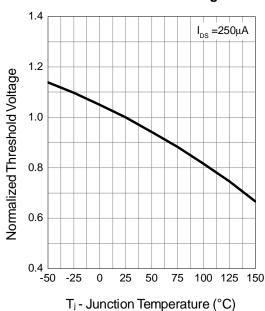
#### Drain-Source On Resistance

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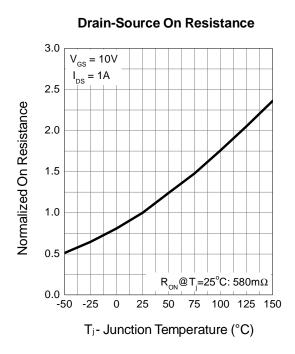
ID-Drain Current (A)



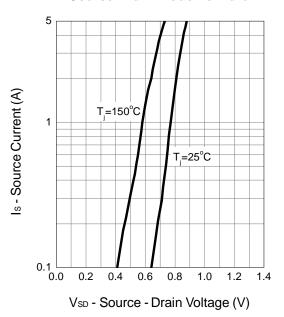
#### Gate Threshold Voltage

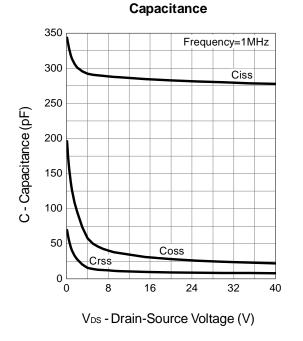


# Typical Operating Characteristics (Cont.)

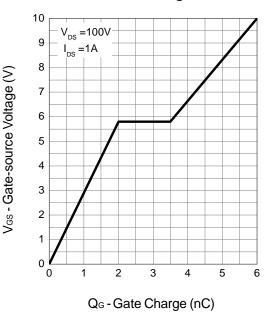


Source-Drain Diode Forward





Gate Charge



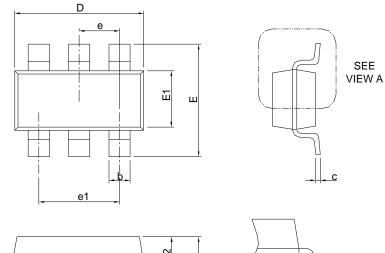
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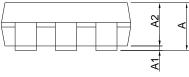


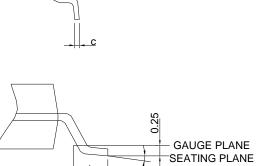
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# Package Information







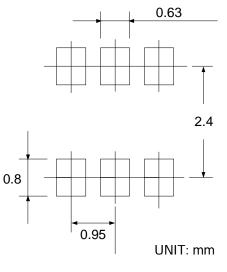
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SEE

VIEW A

**RECOMMENDED LAND PATTERN** 

Ş	Ş SOT-23-6				
S>- <b>∑</b> BO_	MILLIM	ETERS	INC	HES	
P P	MIN.	MAX.	MIN.	MAX.	
Α	-	1.25	-	0.049	
A1	0.00	0.05	0.000	0.002	
A2	0.90	1.20	0.035	0.047	
b	0.30	0.50	0.012	0.020	
с	0.08	0.22	0.003	0.009	
D	2.70	3.10	0.106	0.122	
E	2.60	3.00	0.102	0.118	
E1	1.40	1.80	0.055	0.071	
е	0.95 BSC		0.03	7 BSC	
e1	1.90 BSC		0.075 BSC		
L	0.30	0.60	0.012	0.024	
θ	0°	8°	0°	8°	



Note : 1. Follow JEDEC TO-178 AB.

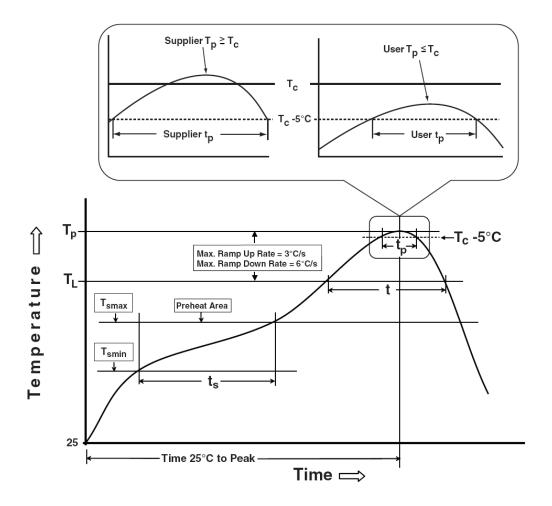
2. Dimension D and E1 do not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 10 mil per side.



WST02N20

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## **Classification Profile**





# **Classification Reflow Profiles**

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly	
$\begin{array}{c} \textbf{Preheat \& Soak} \\ \textbf{Temperature min (T_{smin})} \\ \textbf{Temperature max (T_{smax})} \\ \textbf{Time (T_{smin} to T_{smax}) (t_s)} \end{array}$	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds	
Average ramp-up rate (T <sub>smax</sub> to T <sub>P</sub> )	3 °C/second max.	3°C/second max.	
Liquidous temperature $(T_L)$ Time at liquidous $(t_L)$	183 °C 60-150 seconds	217 °C 60-150 seconds	
Peak package body Temperature (T <sub>p</sub> )*	See Classification Temp in table 1	See Classification Temp in table 2	
Time $(t_P)^{**}$ within 5°C of the specified classification temperature $(T_c)$	20** seconds	30** seconds	
Average ramp-down rate ( $T_p$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.	
Time 25°C to peak temperature	6 minutes max.	8 minutes max.	
* Tolerance for peak profile Temperate ** Tolerance for time at peak profile ter	ure (T <sub>p</sub> ) is defined as a supplier minimu nperature (t <sub>p</sub> ) is defined as a supplier n		

Table 1. SnPb Eutectic Process - Classification Temperatures (Tc)

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> <sup>3</sup> 350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>
Thickness	<350	350-2000	>2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

## **Reliability Test Program**

Test item	Method	Description	
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C	
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ Tjmax	
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ Tjmax	
РСТ	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121℃	
ТСТ	JESD-22, A104	500 Cycles, -65°C~150°C	



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